Item Selection for the Development of Parallel Forms From an IRT-Based Seed Test Using a Sampling and Classification Approach

Pei-Hua Chen¹, Hua-Hua Chang², and Haiyan Wu³

Abstract

Two sampling-and-classification–based procedures were developed for automated test assembly: the Cell Only and the Cell and Cube methods. A simulation study based on a 540-item bank was conducted to compare the performance of the procedures with the performance of a mixed-integer programming (MIP) method for assembling multiple parallel test forms. The study investigated the statistical equivalence of the forms generated by the three test assembly methods (Cell Only, Cell and Cube, and MIP) in terms of test information functions, test characteristic curves, mean square deviations, and practical constraints, such as content balancing and non-overlap among forms. The results indicated that the 13-point MIP method outperformed the other two methods in terms of the “closeness” test information functions between the reference form and the assembled parallel tests. Regarding test characteristic curves, the Cell Only and Cell and Cube methods yielded more similar test characteristic curves than the MIP method. Constraining test information functions apparently does not guarantee that the assembled forms will yield similar test characteristic curves. Overall, the Cell Only and Cell and Cube methods have the potential to provide results similar to the optimization approach.

¹National Chiao Tung University, HsinChu, Taiwan
²University of Illinois at Urbana-Champaign, Urbana-Champaign, IL, USA
³Florida State University, Tallahassee, FL, USA

Corresponding author:
Pei-Hua Chen, National Chiao Tung University, Department of Management Science, 1001 University Road, HsinChu 30010, Taiwan
Email: paulachen@g2.nctu.edu.tw
Large-scale assessments are usually required to administer tests at multiple locations and sessions. Testing agencies and organizations, therefore, typically desire to generate multiple parallel test forms. In recent years, advanced innovations in computer technology and psychometric theory have led to changes in test assembly practices. Most researchers (Breithaupt & Hare, 2007; Finkelman, Kim, & Roussos, 2009; Luecht, 1998; Sanders & Verschoor, 1998; Swanson & Stocking, 1993; van der Linden, 2005; Veldkamp, 2002) solve test assembly problems by using the constrained combinatorial optimization approach, which seeks the values of the decision variables that optimize the objective function, subject to specified constraints (Hillier & Lieberman, 2001). In such a context, a test assembly problem can be treated as trying to match a certain target test information function (objective function) subject to test length and content coverage (constraints).

Optimization approaches to automated test assembly (ATA) identify optimal solution under the specific constraints of statistical and content-related test specifications within a given item bank. Therefore, having successively constructed forms means that items selected for previous forms are removed from the item pool, and new forms are constructed with the remaining items. Thus, forms built later are not nearly as parallel as forms built earlier. A heuristic correction or replacement phase (Swanson & Stocking, 1993; van der Linden, 2005) is usually required to avoid such a problem. Although multiple-form assembly problems can be simultaneously modeled and constructed, the increase in computation time is commensurate with the expansion in the size of the problem. Furthermore, optimization approaches find the optimal test forms based mainly on the objective function; therefore, test forms are not built by means of uniform sampling, meaning that there is an equal chance for each feasible test to be selected (Belov & Armstrong, 2005).

A random search approach has been recently introduced into the area of ATA (Belov & Armstrong, 2005; Chen, 2005; Chen & Chang, 2005, 2006). Unlike the optimization approaches that pick the best possible solutions first, the random search approach has the demonstrable advantage of producing uniform tests (Belov, 2008). One test assembly method, the Monte Carlo random search with tabu search elements (Glover, Taillard, & de Werra, 1993) proposed by Belov and Armstrong (2005), has the major advantage of uniform test assembly. Based on the random search characteristics, each form has an equal chance of selection, thereby avoiding the sequential degradation problem without any need for a second step modification. The present study also proposes a similar randomization-based approach to assemble multiple parallel test forms.

The goal of the present study was to develop two random sampling and classification approaches—the Cell Only and the Cell and Cube methods—to build multiple forms based on a reference form (i.e., a target test or a seed test). The performance of
the proposed methods was measured against the baseline of one of the commonly
used approaches in test assembly: the mixed-integer programming (MIP) method.
This article is organized as follows. We briefly review optimization approaches and
follow with discussion of some of the issues encountered in multiple-form ATA. We
then provide the rationale for our sampling and classification methods. Finally, we
compare test assembly methods using several criteria, such as mean square deviations
between the reference form and the assembled form, target test information func-
tions, and test characteristic curves.

A Brief Review of Optimization Approaches in ATA

Previous studies based on optimization approaches have used the MIP (Breithaupt &
Hare, 2007; van der Linden, 2005; Veldkamp, 2002) and the enumerative heuristic
methods (Finkelman et al., 2009; Luecht, 1998; Luecht & Hirsch, 1992; Sanders &
Verschoor, 1998; Swanson & Stocking, 1993) to tackle various ATA problems. The
MIP method has been popular in test assembly practice mainly because of its flexi-
bility to deal with very complicated test specifications—such as content areas, enemy
items, item type, and word counts—as well as its superiority in assembling numerous
forms with respect to large item banks. For example, the MIP method can specify a
test assembly problem by using a weighted target information function in the objec-
tive function with appropriate constraints to construct forms that can yield uniform
test information functions along the ability scale.

An effective solution to a complicated and large MIP problem usually requires
sophisticated algorithms. Commercial optimization software packages (usually called
solvers), such as the IBM ILOG CPLEX Optimization Studio 12 (IBM, 2009), have
readily built-in algorithms, and they require only very little customized programming.
Large or mid-sized testing organizations can benefit from commercially available sol-
vvers to handle computationally intensive real assembly problems. Furthermore, MIP
results provide a global optimal solution, whereas other heuristic approaches gener-
ally produce a suboptimal solution.

Although the MIP method offers a powerful solution to test assembly problems,
the cost of a commercial license for specialized solvers ranges from hundreds to
thousands of U.S. dollars, which makes it difficult for small or not-for-profit testing
agencies to afford (Davey, 2009). Although free-version solvers are available, such
as the standard solver built in to Microsoft Excel 2007 (Cor, Alves, & Gierl, 2008,
2009), limits on decision variables and constraints make them unsuitable for han-
dling most real test assembly problems. Moreover, while researchers can write their
own MIP code in any programming language, such an undertaking is usually very
complicated and time consuming. Therefore, practitioners are greatly interested in
employing alternative approaches, such as heuristic methods, which can use existing
programming software to assemble test forms, particularly for some testing programs
with relatively simple test specifications.
Issues in Constructing Parallel Test Forms

Meaning of Parallel Test Forms

Parallel test forms are required to be equivalent in terms of their statistical and content-related properties. When the test information functions of alternative test forms are identical, the statistical equivalence of these forms is called weakly parallel in an item response theory (IRT) framework (Samejima, 1977). Most test assembly studies restrict the test information function within a certain range of the target by matching information functions pointwise along the ability scale (Luecht, 1998; van der Linden, 2005). For a new testing program, generating test forms that target a given shape of the test information function is generally useful. There is no need to equate the forms to the reference form.

Although computerized test assembly typically uses test information functions when evaluating parallel test construction, traditional paper-and-pencil forms are assembled according to score distributions. Matching forms using test information functions does not guarantee matched score distributions (Wightman, 1998). However, for an existing assessment, reference forms are available, and it makes sense to build new forms based on the reference form for at least two reasons. First, matching forms item by item guarantees matched test information functions and score distributions. Second, because testing agencies have expended considerable money and effort validating reference forms, their scores are typically more readily interpretable by test professionals. For example, Armstrong, Jones, and Wu (1992) created parallel test forms to match an existing seed test by formulating the test assembly problem into an MIP model. The present study also built parallel forms by matching an existing reference form, but it did so using a different approach that employed random sampling and classification.

A Sequential Versus a Simultaneous Approach

The major challenge of ATA is to construct multiple parallel forms as opposed to a single form. Multiple test forms can be assembled sequentially or simultaneously. A sequential approach assembles forms successively. When building multiple forms...
sequentially based on the optimization approach, the algorithm tends to pick the best set of items for the first form, the second best set of items for the second form, and so on. As the number of assembled forms increases, the later forms are not as nearly parallel as the first form. Therefore, a heuristic correction, such as the Big-Shadow-Test (BST) method (van der Linden, 2005) or a replacement phase (Swanson & Stocking, 1993), is needed to successively replace and swap previously selected items until no further improvement can be made to mitigate such a problem (Swanson & Stocking, 1993; van der Linden, 2005).

Conversely, building forms sequentially based on the randomization approach does not cause deterioration problems because of its stochastic nature. Earlier built forms are not necessarily superior to or inferior to their successors. Therefore, it is worth exploring the feasibility of applying the randomization approach in test assembly.

Another approach is to assemble forms simultaneously based on the MIP method as proposed by Boekkooi-Timminga (1990). The simultaneous approach builds multiple test form assembly problems into a single model, using new decision variables to link item-level and form-level variables. This approach builds the required forms all at the same time and is known to be computationally intensive; computation time increases exponentially as problem size grows. Solving an MIP problem requires exponential running time in general, and so the solution time for the MIP method depends highly on the computer processor and the memory space in the hardware. For example, using quad core capability processors can halve the solution time or even reduce it further. Such high-speed processors and high-capacity memories are quite common in most modern computers, so they can help reduce the solution time for large MIP problems.

**Rationale for the Sampling and Classification Approaches**

The rationale for the sampling and classification approaches is somewhat similar to the method of “matched random subsets,” which constructs parallel tests based on the classical test theory proposed by Gulliksen (1950). Under the matched random subsets method, items that are close to one another on the scatter diagram of item difficulty ($p$) and the point–biserial correlation with total test score ($r_{pbs}$) are grouped into “subsets.” Items selected from each subset are randomly assigned to each of the required forms. Matching items based on item statistics and assigning them to subsets ensures parallel subsets and thus parallel test forms (Gulliksen, 1950).

The IRT-based sampling and classification approach to ATA uses a similar rationale to use the joint distribution of item parameter values, which determine the individual item information functions and the collective test information function. In a three-parameter logistic (3PL) IRT model, the item information function is determined by three item parameters—for item discrimination, item difficulty, and item guessing ($a_i, b_i, c_i$)—and one examinee ability parameter ($\theta$). If $\theta$ is approximated close to $b_i$, then the larger the value of $a_i$, the larger the value of item information.
Item information values, in other words, are mainly determined by the item discrimination parameter \( (a_i) \), which is conditional on ability level.

The relationship of item information functions to the item parameters used in computerized adaptive testing can also be applied in ATA. If the joint distribution of \( a \)- and \( b \)-parameters for a reference form is already known, then the target test information curve across ability levels can be determined. That is, mimicking the item parameter distribution of the reference form results in achieving the target test information. Therefore, if the scatter plot of the \( a \)- and \( b \)-parameters in the reference form is provided, the task of assembling a statistically equivalent test becomes the task of creating another scatter plot, with the new test having a joint distribution of \( a \)- and \( b \)-parameters similar to the reference form.

**Cell Only Method**

Mimicking the scatter plot of \( a \)- and \( b \)-parameters in the reference form is not easy. Classification of the item pool and reference form, however, can play a crucial role in simplifying the process. Items in the pool and reference form can be partitioned into \( M \) groups from \( m = 1, \ldots, M \) according to their \( a \)-parameters. Similarly, items can be divided into \( N \) groups from \( n = 1, \ldots, N \) according to their \( b \)-parameters. Thus, the scatter plot of the \( a \)- and \( b \)-parameters for the whole item pool and the reference form can be categorized into \( M \times N = MN \) cells. Figure 1 shows a representation of the item pool categorization for the Cell Only method. The values of \( a \) parameters in Figure 1 are between 0 and 3 and are categorized into six groups, whereas the values of \( b \) parameters are between \(-4 \) and \( 4 \) and are categorized into four groups. Item selection under this method involves randomly selecting the number of items within each cell in the reference form from the item pool such that the number of items from each cell in the reference form and in the assembled test is the same. This process
approximates the joint distribution of the \( a \)- and \( b \)-parameters and is called the Cell Only method.

**Cell and Cube Method**

Although the Cell Only method appears to be a reasonable approach, some items in the pool remain unselected if there is no item in the corresponding cell in the reference form. To improve item pool utilization and the item exposure rate, the present study introduced a two-stage sampling method: the Cell and Cube method.

Van der Linden (2005) proposed a BST method to solve a large simultaneous ATA problem by treating it as a sequence of smaller simultaneous problems. Current constructed forms are assembled along with a shadow test that includes the remaining test items in the pool. Items in the shadow test are returned to the pool once current forms are built. This process is repeated until all test forms are constructed.

The Cell and Cube method is similar to the BST method in the sense that both decompose a big problem into a series of smaller subproblems and the test items are partially filled up at each stage. Under the BST method, the variation in the number of subproblems depends on the number of forms one tries to build, whereas under the Cell and Cube method there are only two stages, making it a special case of the BST method.

Luecht and Hirsch (1992) proposed a heuristic search to iteratively calculate the moving average of the differences between target information and previously selected items as the basis for sequentially selecting the next item. This algorithm tends to select items with moderate information at each iteration. The proposed Cell and Cube method tries to improve the selection probability of items with relatively low or high information. This method is described below.

Suppose the test length of the reference form is \( n \) and that \( n_1 \) items were selected during the cell stage. Then, \( n_2 \) items will be selected during the cube stage, where \( n = n_1 + n_2 \). Test information functions are smooth and well-behaved continuous curves, and optimizing a test information function with three to five well-chosen ability points is appropriate (van der Linden, 2005). Suppose we consider \( T \) ability points at \( \theta_t \) \((t = 1, \ldots, T)\). We then have \( T \) target test information values \([T(\theta_1), T(\theta_2), \ldots, T(\theta_T)]\).

The value of the target test information \( T(\theta_t) \) at ability point \( \theta_t \) can be decomposed into two parts: the target test information for the cell stage \( (T_1(\theta_t))\) and the target test information for the cube stage \( (T_2(\theta_t))\), where \( T(\theta_t) = T_1(\theta_t) + T_2(\theta_t) \). After selecting items during the cell stage, the required test information function for the cube stage can be determined to be \([T_2(\theta_1), T_2(\theta_2), \ldots, T_2(\theta_T)]\). If there are \( n_2 \) items to be selected during the cube stage, the average contribution of each item to the new target information function can be written as

\[
\begin{bmatrix}
\frac{T_2(\theta_1)}{n_2}, & \frac{T_2(\theta_2)}{n_2}, & \ldots, & \frac{T_2(\theta_T)}{n_2}
\end{bmatrix} = \begin{bmatrix}
\bar{T}_2(\theta_1), & \bar{T}_2(\theta_2), & \ldots, & \bar{T}_2(\theta_T)
\end{bmatrix}.
\]

The item information at \( \theta_t \) for each item \( i \) in the subpool can be calculated as \([I_i(\theta_1), I_i(\theta_2), \ldots, I_i(\theta_T)]\).
The standard deviations of the item information functions at $T$ ability points in
the item pool can also be obtained, $(s(\theta_1), s(\theta_2), \ldots, s(\theta_t))$. Because only a few
items are selected in the cell stage, using the complete item pool to calculate the
standard deviation of item information at three ability points is appropriate. If the
subpool is divided into $K$ categories by $T$ item information functions at
$T$ ability levels, the subpool will be categorized into $K^T$ cubes. The partition points
of the $K$ categories can be determined by the required average target information
function per item $T_2(\theta_t)$ and the standard deviation of the item information $s(\theta_t)$ at
$T$ ability points. When three ability points ($T = 3$, $\theta_t = -1$, 0, and 1) and three
item information categories ($K = 3$) are considered, the information function of
an item for each ability point $\theta_t$ can be categorized as below $T_2 (\theta_t) - s(\theta_t)$,
between $T_2 (\theta_t) - s(\theta_t)$, and above $T_2 (\theta_t) + s(\theta_t)$. The cutoff points for dividing
the item subpool into $3^3$ cubes are $T_2 (\theta_t) - s(\theta_t)$ and $T_2 (\theta_t) + s(\theta_t)$, where $\theta_t = -1$, 0,
and 1.

Now each item can have an address $d_{\theta_t}$ ($\theta_t = -1, 0, 1$) for the cube it belongs to
($d_{-1}, d_0, d_1$). Any item $i$ in the subpool can be put into one of the three groups
according to its item information $I_i(\theta_t)$ at each ability point $\theta_t$:

\[ I_i(\theta_t) \leq T_2 (\theta_t) - s(\theta_t), \quad (d_{\theta_t} = -1), \quad (1) \]
\[ \bar{T}_2 (\theta_t) - s(\theta_t) < I_i(\theta_t) < \bar{T}_2 (\theta_t) + s(\theta_t), \quad (d_{\theta_t} = 0), \quad (2) \]
and
\[ I_i(\theta_t) \geq \bar{T}_2 (\theta_t) + s(\theta_t), \quad (d_{\theta_t} = 1). \quad (3) \]

Matrix 4 shows the categorization into three groups of the information function
values at three ability levels ($\theta_t = -1, 0, 1$), which can be coded accordingly as in
Matrix 5. Figure 2 shows a representation of the information function divided into
three groups at three ability points.

\[
\begin{bmatrix}
\leq \bar{T}_2 (1) - s(1), & \leq \bar{T}_2 (0) - s(0), & \leq \bar{T}_2 (1) - s(1) \\
\bar{T}_2 (1) - s(1) - \bar{T}_2 (1) + s(1), & \bar{T}_2 (0) - s(0) - \bar{T}_2 (0) + s(0), & \bar{T}_2 (1) - s(1) - \bar{T}_2 (1) + s(1) \\
\geq \bar{T}_2 (1) - s(1), & \geq \bar{T}_2 (0) + s(0), & \geq \bar{T}_2 (1) + s(1)
\end{bmatrix}
\]

\[
\begin{bmatrix}
\theta_{-1} = -1, & d_0 = -1, & d_1 = -1 \\
d_{-1} = 0, & d_0 = 0, & d_1 = 0 \\
d_{-1} = 1, & d_0 = 1, & d_1 = 1
\end{bmatrix}
\]

After the subpool is categorized into 27 cubes, each item can only belong to one
cube. Now, we can select $n_2$ items in the subpool according to the following
algorithm:

**Step 0:** Items are selected in pairs ($x$ and $y$).

**Step 1:** Select item $x$ randomly from the subpool and notice its address according
to the cube it belongs to, denoted [$d_{x,-1} = -1, d_{x,0} = 0, d_{x,1} = -1$].
Step 2: Select item $y$ such that its address, denoted $d_y$, satisfies $(dx_{t-1}, dy_{t-1}, dx_t, 0 + dy_t, dx_{t+1}, dy_{t+1}) = (0, 0, 0)$.

Step 3: Repeat Steps 1 and 2 until all $n_2$ items are selected.

Figure 3 shows a representation of the selection for each pair of items. The purpose of using the algorithm is to select each pair of items so that the sum of these $n_2$ information functions equals the target test information $T_2(\theta_t)$ at the cube stage, by keeping the average of the two items in proximity to the average of the target information per item $(T_2(\theta_t))$. If the number of required items in the cube stage ($n_2$) is odd, the last item will be selected based on the difference between the current sum of the item information functions $\sum_{i=n_1+1}^{n} I_i(\theta_t)$ of the $n_2 - 1$ items from the cube stage and the target test information for the cube stage $(\bar{T}_2(\theta_t))$ at each ability level $\theta_t$. If for any selected item $x$ there cannot be found a corresponding item $y$ that satisfies the requirement that the sum of the addresses of item $x$ and $y$ is zero $(dx_{t, \theta_t} + dy_{t, \theta_t} = 0)$ for each ability point $\theta_t$, the selected item $x$ will not be included in the constructed test. Another item will be selected until a corresponding item can be found. In this way, the average item information values of each pair of selected items at each ability level will be close to the average required test information function per item $(\bar{T}_2(\theta_t))$ at ability point $\theta_t$ $(t = 1, \ldots, T)$. As a result, the sum of the selected items is close to the required test information function at ability level $\theta_t$ $(t = 1, \ldots, T)$.

Method

One 540-item retired item pool from a large-scale assessment with three content areas was used. The reference form was composed of 30 items—12 items from Content...
Area A, 9 items from Content Area B, and 9 items from Content Area C. Five forms were constructed by means of each test assembly method (MIP, Cell Only, and Cell and Cube) based on the reference form.

**Item Pool and Reference Form Classification**

Using the Cell Only method and executing the cell stage in the Cell and Cube method require the classification of the item pool and the reference form according to their item discrimination ($a$) and item difficulty ($b$) parameters. Because there were three content areas, the item pool and reference form were first divided into three subpools and three target subtests by content. Both the $a$- and $b$-parameters in the target subtest and item subpool for each content area were then classified. Preliminary experimentation determined that the use of only four $a$-groups and four $b$-groups was inadequate to provide a scatter plot similar to that of the reference form. Therefore, the scatter plots of the $a$- and $b$-parameters for the subpools and the target subtests were divided into four times eight—that is, 32—cells for the sampling and classification approach. First, the $a$-parameters were categorized into four groups: (a) $a \leq 0.7$, (b) $0.7 < a \leq 1.0$, (c) $1.0 < a \leq 1.3$, and (d) $a > 1.3$. Similarly, the $b$-parameters were divided into eight groups: (a) $b \leq -3.0$, (b) $-3.0 < b \leq -2.0$, (c) $-2.0 < b \leq -1.0$, (d) $-1.0 < b \leq 0.0$, (e) $0.0 < b \leq 1.0$, (f) $1.0 < b \leq 2.0$, (g) $2.0 < b \leq 3.0$, and (h) $b > 3.0$. 

**Figure 3.** An example of selecting one pair of items in the Cube stage

Note: The first item has an address of $(-1, 0, -1)$, and the second item (corresponding item) has an address of $(1, 0, 1)$.
**Item Selection Method**

**MIP method.** To determine whether a sampling and classification approach could produce results the same or better than results obtained with MIP, a Minimax model (van der Linden, 2005) of the MIP method was used as a baseline. The Minimax model ensures that the largest deviation between the information function of the assembled test and the target test is minimized by means of a fixed test information function. That is, the Minimax model builds test forms by minimizing the absolute maximum deviation from the points of the specified target test information function. The software GAMS (GAMS, 2007) and the CPLEX solver (IBM, 2009) were used to solve the Minimax model. Considered in the formula of the Minimax model were two different sets of reference form values at 5 and 13 ability points ($\theta = (-2, -1, 0, 1, 2)$ and $\theta = (-3, -2.5, -2, -1.5, -1, -0.5, 0, 0.5, 1, 1.5, 2, 2.5, 3)$), along with three content constraints of 12, 9, and 9 items for each content area. Variables were set up to link item-level and test-level constraints. Five 30-item forms were constructed simultaneously for each set of ability points to fit the target test information function, with the constraints of number of forms, content coverage, and no overlap among forms. Separate objective functions with random coefficients were used to deal with the simultaneous approach, multiple-forms test assembly problem, as suggested by Luecht (1998).

**Cell Only method.** The item pool and reference form were divided into three subpools and three target subtests according to the content areas. Five subtest forms from each content area were randomly selected sequentially without replacement from three subpools according to the number of items per cell in the target subtest, to construct five 30-item test forms.

**Cell and Cube method.** The first stage of the Cell and Cube method randomly selected 10, 7, and 7 items from the tests assembled using the Cell Only method from Content Areas A, B, and C, respectively. The remaining items in each content area created one new subpool for the Cube stage. The values of the item information function at the three ability points ($-1, 0, 1$) were calculated for each item in each new subpool. The test information function was obtained for each subtest form from each content area constructed using the Cell Only method. By similar means, the sums of the selected 10-, 7-, and 7-item information values from the cell stage in the three content areas for each subtest form were also computed. The required subtest information function values for each content area at the three ability points ($-1, 0, 1$) for the cube stage were obtained using the test information function from the Cell Only method for each subtest form, minus the sum of the selected items at the cell stage. Furthermore, the averages of each assembled item that contributed to the cube stage of the target information function for the five forms in each content area were obtained. The standard deviations of the item information function at the three ability points ($-1, 0, 1$) in each new subpool were also calculated. The cutoff points for dividing the cubes in each new pool for five forms differed, because the required test information functions at the cube stage for the five forms were not identical. Finally, the three new subpools were divided into $3 \times 3 \times 3 = 27$ cubes using three item information functions at the three ability levels ($-1, 0, 1$).
Evaluation Criteria

Several criteria were used to evaluate the results of applying the different methods for constructing forms. The first criterion was whether the test information functions produced by the three methods were similar. The test information functions of all the assembled tests and the reference form were plotted on the same scale, because one characteristic of the Minimax model (van der Linden, 2005) is that, if the two test information curves in the Minimax model are as close as possible, the tests are treated as statistically equivalent. That is, neither positive nor negative deviations from the target information are desired under this model. Therefore, the test characteristic curves of the three methods were compared visually to determine whether they were close to one another. Test characteristic curves relate ability to number-correct true scores, and they are widely used in test equating and scaling. Therefore, the test characteristic curve was also included in the evaluation criteria.

The second criterion was a mean square deviation (MSD) statistic, which was used to evaluate the closeness of fit between the assembled tests and the reference form, both for the test information functions and test characteristic curves. The value of the mean square deviation was determined by calculating the deviations of points from their desired target value, summing the measurements, and then dividing by the number of points:

\[
\sum_{i=1}^{n} \frac{\left[ (TI_{obs}(\theta_i) - TI_{tgt}(\theta_i))^2 \right]}{n} \quad \text{(6)}
\]

\[
\sum_{i=1}^{n} \frac{\left[ (TC_{obs}(\theta_i) - TC_{tgt}(\theta_i))^2 \right]}{n} \quad \text{(7)}
\]

In Equation 6, \(TI_{obs}(\theta_i)\) indicates the test information of an assembled test at ability level \(\theta_i\), for every \(i = 1, \ldots, n\). Similarly, \(TI_{tgt}(\theta_i)\) indicates the target test information function values at ability level \(\theta_i\), for every \(i = 1, \ldots, n\). In Equation 7, \(TC_{obs}(\theta_i)\) indicates the test characteristic curve of an assembled test at ability level \(\theta_i\), for every \(i = 1, \ldots, n\). Similarly, the \(TC_{tgt}(\theta_i)\) indicates the test characteristic curve of the reference form. In the present study, 61 ability points, ranging from \(-3\) to \(3\) in increments of 0.1 units, were considered for both the test information function and the test characteristic curve.

Results

Figures 4 and 5 show the test information functions resulting from the MIP method, constraining on 5 and 13 ability points. Figure 4 shows that the information functions fit almost perfectly around the 5 ability point constraints. The item information functions deviated from the targets, both positively and negatively, between ability levels ranging from 0 to 1 and 1 to 2. This pattern indicates that only specifying three to five
target test information function values in the MIP method may be insufficient. Figure 5 shows that almost every assembled curve of the test information function was close to the target information function at every ability point.

Figures 6 and 7 show the test information function curves from the Cell Only and Cell and Cube methods. In the case of the Cell Only method, one form of the test information curves deviated from the target moderately in the positive direction, ranging from ability points -0.5 to 0.5, whereas another form also deviated positively between ability points 1.6 and 2.5. Additionally, two forms of the test information curves deviated slightly from the target in the negative direction between ability points -0.4 and 2. Figure 7 shows that two forms from the Cell and Cube method deviated from the targets in the positive direction, predominantly between ability points 0 and 1. One form deviated slightly from the target in the negative direction, ranging from ability points -0.2 to 1. Two forms deviated from the target, ranging from ability points 1 to 3 in both the positive and negative directions.

Figures 8 and 9 show the test characteristic curves for the MIP method with 5- and 13-point constraints of the test information function. In Figure 8, most of the test characteristic curves shifted to the left in the positive direction, whereas three forms deviated from the target in the negative direction at high ability levels. Unexpectedly, the test characteristic curves of the forms with the 13-point constraints on the test information function shown in Figure 9 were not close to each other. The deviations increased in the positive direction when ability levels decreased, starting from the ability point of 1. For the Cell Only method, most of the test characteristic curves in Figure 10 were close to the target, except for one form that slightly deviated in the
negative direction for ability points between $-0.6$ and $-3$. For the Cell and Cube method, the test characteristic curves in Figure 11 slightly deviated from the target in both the negative and positive directions. The test characteristic curve results show, overall, that the Cell Only and Cell and Cube methods outperformed the MIP methods. The 13-point MIP method did not generate closer test characteristic curves, as expected. The 5-point MIP method yielded the largest deviations from the target.
Tables 1 and 2 list the mean, the standard deviation, the maximum and minimum values for the mean square deviation of the five forms from the target test information, and the test characteristic curve at 61 ability points for all test assembly

Figure 7. Test information functions of the Cell and Cube method

Figure 8. Test characteristic curves of the 5-point mixed-integer programming method
methods, respectively. Table 1 shows that the 13-point MIP method yielded the smallest mean (0.002) and standard deviation (0.003). Although the mean for the Cell
Only method was similar to that for the Cell and Cube method, it had a smaller standard deviation. The results for the 5-point MIP method exhibited the largest mean and standard deviation among the four methods. In Table 2, the mean square deviations from the test characteristic curve of the reference form show that the Cell Only and Cell and Cube methods yielded similar results, with the smallest means and standard deviations of MSD. The 13-point MIP method did not yield better results than did the Cell approach, whereas the MIP with a 5-point constraint yielded the largest mean and standard deviations of test characteristic curve MSD.

### Discussion and Conclusions

Current ATA methods have lightened the burden of the labor-intensive work of item selection; however, most of them are essentially based on similar concepts of
constrained combinatorial optimization. Various methods belonging to the optimization approach have been applied to real testing programs, such as the Law School Admission Test, and they have shown promising results. Commercial discrete optimization solvers and modeling systems make it convenient to model and specify complicated test assembly problems through syntax. However, the educational measurement community is generally unfamiliar with such software and their associated platforms (Cor et al., 2009). Psychometricians usually require additional optimization-related knowledge and programming competence. Therefore, it will be interesting to see how this field develops as more alternatives become available, which may provide simpler solutions.

The results show that the 13-point MIP method performed the best among the four item selection methods, in terms of hitting target test information curves and possessing the smallest mean square deviation of test information function curves. However, the test characteristic curve results show that the Cell Only and Cell and Cube methods yielded more closely matching test characteristic curves than did the 13-point MIP method. Therefore, by optimizing test information function curves with respect to several well-chosen test information function points, the MIP method could provide the most test information function curves well-fitted to the reference form. However, it appears that constraining test information function points does not exclusively guarantee the generation of similar test characteristic curves, also known as true score, which is typically the basis for determining statistical equivalence in test equating. The Cell Only and Cell and Cube methods did not yield better results than did the 13-point MIP method in terms of test information functions, yet they provided relatively consistent results in hitting both the target test information functions and test characteristic curves.

The principal contribution of the present study has been to develop a new sampling-and-classification method as a protocol to construct parallel forms from a seed test. It has also contributed to the development of a concept that is simple to comprehend and an easy implementation procedure, particularly for tests with simple test specifications. Writing MIP programs to solve the problem of ATA without commercial software is usually very costly in terms of time and effort. Large-scale

Table 2. Descriptive Statistics of the Mean Square Deviation From the 61 Target Test Characteristic Curves of Five Forms

<table>
<thead>
<tr>
<th>Method</th>
<th>Mean Square Deviation From the Target Information</th>
</tr>
</thead>
<tbody>
<tr>
<td></td>
<td>Mean</td>
</tr>
<tr>
<td>Five-point MIP method</td>
<td>1.934</td>
</tr>
<tr>
<td>Thirteen-point MIP method</td>
<td>1.246</td>
</tr>
<tr>
<td>Cell Only method</td>
<td>0.115</td>
</tr>
<tr>
<td>Cell and Cube method</td>
<td>0.115</td>
</tr>
</tbody>
</table>

Note: MIP = mixed-integer programming.
assessments with complicated test constraints could benefit from the power of an optimization solver to build desired forms very quickly. The sampling and classification method is suitable for testing programs with simple test specifications and for testing agencies with limited budgets. This method mimics the joint distribution of $a$- and $b$-parameters and is more intuitive, making it easier for most educators and researchers to understand.

The Cell Only and Cell and Cube methods presented here are simplified versions. This approach could be further modified to make it more practical. Before applying the Cell Only and Cell and Cube methods to operational item banks, other issues must be addressed. First, the number of cells and cubes, and the cutoff points to be used, is intuitive. When specifying the cutoff points of cells and cubes, test constructors should consider several factors, including item pool size, the composition of item parameters in the item bank, and test specifications. Second, although this study incorporated simple nonstatistical characteristics, such as content specifications, real tests might include complicated test specifications, such as item type, enemy items, or set-based items. The present study should be viewed as the first of a series of studies in the development of a sampling and classification approach to ATA. Further research is underway on how to incorporate content balancing techniques or to satisfy complex test specifications based on this approach.

**Acknowledgments**

The authors would like to thank Jiahe Qian for his telephone consultations. Thanks also to Barbara Dodd, George Marcoulides, Hsiao-Cheng Yu, and two anonymous reviewers for their useful comments on earlier versions of this article. Special thanks to Daniel Junglas and Ming Lei for their useful comments during the revision.

**Authors’ Note**

This article was in part prepared while the first author was Assistant Professor in the Department of Educational Psychology and Learning Systems at Florida State University, Tallahassee, FL, USA.

**Declaration of Conflicting Interests**

The author(s) declared no potential conflicts of interest with respect to the research, authorship, and/or publication of this article.

**Funding**

The author(s) disclosed receipt of the financial support for the research, authorship, and/or publication of this article: The National Academy for Educational Research of Taiwan, NAER-100-24-B-2-02-00-2-02, and the National Science Council of Taiwan, NSC100-2511-S-009-005, partially supported the work of Pei-Hua Chen. The Department of Educational Psychology and Learning Systems partially supported the work of Pei-Hua Chen and Haiyan Wu.
References


